

<b>Notice of References Cited</b>	Application/Control No. 09/974,025	Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Nitin Parekh	Art Unit 2811	Page 1 of 2

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,440,833	08-2002	Lee et al.	438/601
	B	US-6,649,997	11-2003	Koike, Hidetoshi	257/529
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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